



NOTES:

1. OPERATION WAVELENGTH: 180 nm-8.0 μm
2. CLEAR APERTURE (S1,S2,S3) : >70%CA
3. ANGLE TOLERANCE: <10 arcmin
4. SURFACE QUALITY (S1,S2,S3) : 60/40 (S/D)
5. SURFACE FLATNESS (S1,S2,S3) : λ/4@632.8 nm
6. CHAMFER: <0.2 mm, 45°
7. COATING (S1,S2,S3) : UNCOATED
8. OTHER SURFACES: FINE GROUND

DRAWING PROJECTION			LBTEK			
	NAME	DATE	RAP725			
DRAWN	LZHOU	MAR./15th/24	RIGHT ANGLE PRISM L x H=25.0 mm x 25.0 mm, UNCOATED			
APPROVAL	WCHENG	MAR./15th/24	MATERIAL	WEIGHT	SCALE	REV
FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES			CAF2	19.60g	5:2	B